

<b>Form PTO-1449 (MODIFIED) TRADEMARK</b>  <b>INFORMATION DISCLOSURE CITATION</b>  (Use several sheets if necessary)	<b>U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE</b>	<b>ATTY. DOCKET NO.</b> 054821-0116	<b>SERIAL NO.</b> 09/898,660
	<b>APPLICANT</b> Schaeffer et al.		
	<b>FILING DATE</b> 07/02/2001	<b>GROUP ART UNIT</b> 1745	

**U.S. PATENT DOCUMENTS**

EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB- CLASS	FILING DATE IF APPROPRIATE
Only	A1	6,117,594	09/12/2000	Taylor et al.			
Only	A2	6,057,059	05/02/2000	Kwok et al.			
Only	A3	6,037,081	03/14/2000	Kashio et al.			
Only	A4	5,989,749	11/23/1999	Kao et al.			
Only	A5	5,643,696	07/01/1997	Rowlette			
Only	A6	5,462,109	10/31/1995	Vincze et al.			
Only	A7	5,344,727	09/06/1994	Meadows et al.			
Only	A8	5,024,908	06/18/1991	Terada et al.			
Only	A9	4,939,051	07/03/1990	Yasuda et al.			
Only	A10	4,865,933	09/12/1989	Blanyer et al.			
Only	A11	4,865,928	09/12/1989	Richter			
Only	A12	4,805,277	02/21/1989	Yasuda et al.			
Only	A13	4,782,585	11/08/1988	Kobayashi et al.			
Only	A14	4,761,356	08/02/1988	Kobayashi et al.			
Only	A15	4,606,383	08/19/1986	Yanik			
Only	A16	4,498,519	02/12/1985	Watanabe et al.			
Only	A17	4,460,666	07/17/1984	Dinkler et al.			
Only	A18	4,386,987	06/07/1983	Covitch et al.			
Only	A19	4,349,067	09/14/1982	Wirtz et al.			
Only	A20	4,315,356	02/16/1982	Laurie et al.			
Only	A21	4,297,866	11/03/1981	Sakauye et al.			
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Only	A22	4,140,840	02/20/1979	Ruben			
Only	A23	4,107,407	08/15/1978	Koch			
Only	A23	4,097,625	06/27/1978	Lunn et al.			
Only	A24	3,929,513	12/30/1975	Mao			
Only	A25	3,926,247	12/16/1975	Geiger et al.			

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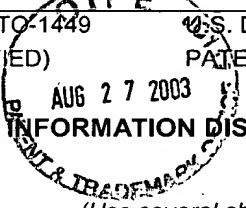
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EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB- CLASS	FILING DATE IF APPROPRIATE
Only	B1	3,349,067	10/24/1967	Hill			
Only	B2	2,282,760	05/12/1942	Hauel			
Only	B3	2,193,782	03/12/1940	Smith			
Only	B4	1,500,219	07/08/1924	Benner			

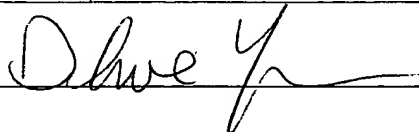
## FOREIGN PATENT DOCUMENTS

	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION	
							YES	NO
Only	B5	WO 02/054513 A2	07/11/2002	PCT				
Only	B6	WO 99/27595	06/03/1999	PCT				
Only	B7	EP 0 795 917 A2	09/17/1997	EPO				
Only	B8	EP 0 348 702 A1	01/03/1990	EPO				

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

Only	B9	PCT International Search Report for PCT/US02/00390 dated 08/19/2002.						
Only	B10	PCT International Search Report for PCT/US00/18114 dated 10/09/2000.						
Only	B11	Patent Abstract for JP 58075772.						
Only	B12	Office Action dated 06/18/2003 for Application Serial No. 09/755,337.						
Only	B13	Office Action dated 01/07/2003 for Application Serial No. 09/755,337.						
Only	B14	Office Action dated 09/16/2002 for Application Serial No. 09/755,337.						
Only	B15	Copy of U.S. Patent Application Serial No. 09/755,337, titled "Method For Making An Alloy Coated Battery Grid," by Yu-Lin Chen.						
Only	B16	Ishikawa et al., "A punched grid production process for automotive batteries" from Pb 80, 7 <sup>th</sup> International Conference.						

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APPLICANT

Schaeffer et al.

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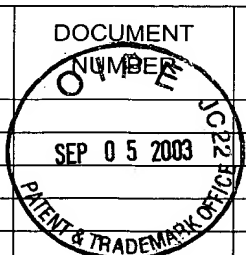
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	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION	
							YES	NO
Dwy	A1	JP8287905	11/01/1996	Muneyoshi et al.				X
Dwy	A2	JP8083617	03/26/1996	Katsuhiko et al.				X
Dwy	A3	JP5275081	10/22/1993	Hideo et al.				X
Dwy	A4	JP5036416	02/12/1993	Takeaki et al.				X
Dwy	A5	JP3030260	02/08/1991	Yasushi				X
Dwy	A6	JP2297864	12/10/1990	Naoto et al.				X
Dwy	A7	JP1030168	02/01/1989	Masaaki et al.				X
Dwy	A8	JP63213264	09/06/1988	Shinji et al.				X
Dwy	A9	JP61124052	06/11/1986	Tadashi et al.				X
Dwy	A10	JP60198055	10/07/1985	Hirofumi et al.				X
Dwy	A11	JP60167268	08/30/1985	Hirofumi et al.				X
Dwy	A12	JP60167267	08/30/1985	Yukihiro				X
Dwy	A13	JP60143570	07/29/1985	Toshihiro et al.				X
Dwy	A14	JP60039766	03/01/1985	Yoshihiro et al.				X
Dwy	A15	JP60037663	02/27/1985	Yoshihiro et al.				X
Dwy	A16	JP59134563	08/02/1984	Katsuhiko et al.				X
Dwy	A17	JP58066266	04/20/1983	Sukeyasu				X
Dwy	A18	JP58032367	02/25/1983	Katsuhiko et al.				X
Dwy	A19	JP57205969	12/17/1982	Yukihiro				X
Dwy	A20	JP56167271	12/22/1981	Akira				X
Dwy	A21	JP56165279	12/18/1981	Naoto et al.				X
Dwy	A22	JP56138872	10/29/1981	Yuji				X
Dwy	A23	JP56107474	08/26/1981	Takeshi				X
Dwy	A24	JP56032678	04/02/1981	Ryosuke				X
Dwy	A25	JP55144659	11/11/1980	Takeshi				X
Dwy	A26	JP55130076	10/08/1980	Imakichi et al.				X

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

Dwy	A27	Patent Abstract for JP 3245462.
Dwy	A28	Patent Abstract for AU 275685.

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